


<b>Search Notes</b>  	<b>Application/Control No.</b>  10751475	<b>Applicant(s)/Patent Under Reexamination</b>  INOUE, HARUO
	<b>Examiner</b>  Kim, Andrew	<b>Art Unit</b>  3714

SEARCHED			
Class	Subclass	Date	Examiner
463	16-21, 30-33	6/8/2007	AK
273	143R, 138.1	6/8/2007	AK

SEARCH NOTES			
Search Notes		Date	Examiner
16			

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner